

## Microscopes



Measuring and inspection microscopes with different configurations for semiconductors / MEMS applications. They are characterized by the highest optical performance with fast and easy operation.

[More Information](#)

## Inspection & Metrology



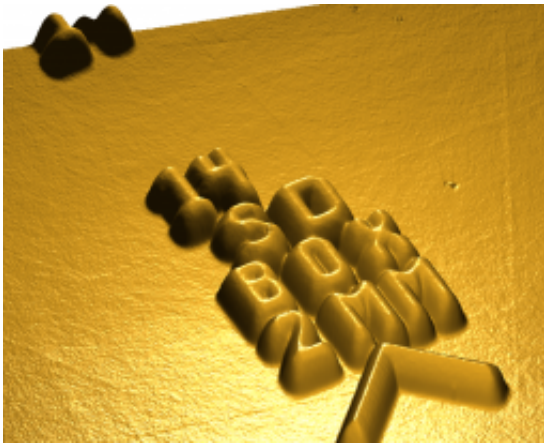
### **PROMIS**

Promicon Inspections & Metrology Systems

- Fully automatic
- Flexible use
- For Inspection and Metrology

[More Information](#)

## White Light Interference

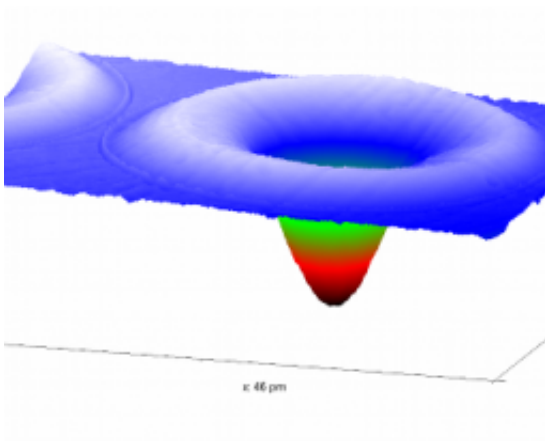


### **PRO-WLI**

Microscope equipment based on INM200/Ergoplan or DM8000 with interferometer hardware & software for topography measurement and export of 3D data.

[More Information](#)

### **Confocal Microscopy**

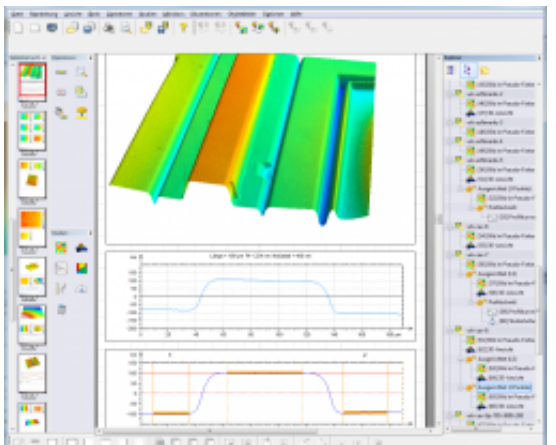


### **PRO-CON**

Microscope confocal module as an upgrade for high resolution 3D Metrology.

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### **Software MCS**

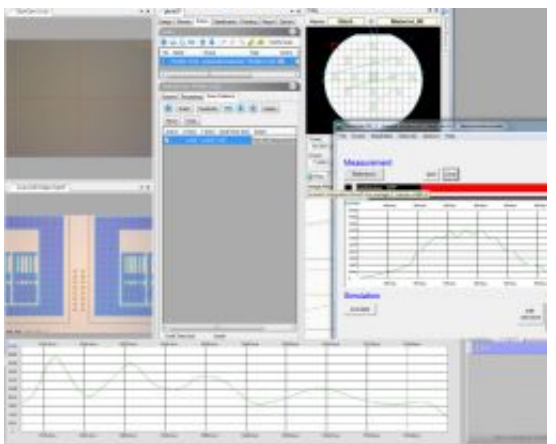


## Modular Software Suite MCS:

- Inspection
- Review
- Metrology (CD, confocal,...)
- Hardware control

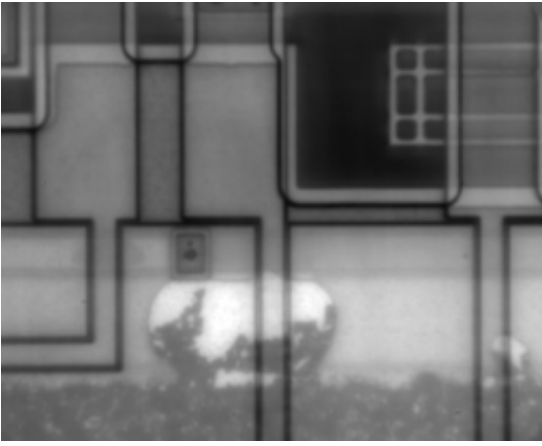
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## Thin Film Measurement



[More Information](#)

## Infrared Systems



[More Information](#)